Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/091,269	MIYATA ET AL.
Examiner	Art Unit

Thierry L. Pham

2625

	SEARCHED					
Class	Subclass	Date	Examiner			
358	1.1	2/27/2007	TP			
	1.9	2/27/2007	TP			
	1.11-1.18	2/27/2007	TP			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
East Search (results attached)	2/27/2007	тР	
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